

providing a wet etching to remove a final one of said multiple layers; and providing a base region above said collector region in the horizontally etched area; providing an emitter region above the base region so that the emitter, base and collector regions are super self-aligned.

8. (Amended) A super self-aligned pipolar transistor apparatus, comprising:

a semiconductor substrate having a buried collector region;

multiple layers above said collector region;

an emitter window mask above said multiple layers;

a doped collector region wherein the width of the doped collector region are equal to the emitter window mask width;

a horizontally etched region of one of said multiple layers, wherein the dimensions of the horizontally etched region determine that the dimensions of the base region are wider than the doped collector region and the emitter region of the transistor;

a base region above said collector region in the horizontally etched region;

an emitter region above the base region so that the emitter, base and collector regions are super self-aligned.

18. (Amended) A method for forming a super self-aligned bipolar transistor, comprising the steps of:

providing a silicon semiconductor substrate having a buried collector region;

providing a first oxide layer, a polysilicon layer, and a second oxide layer above said collector region;

providing a Nitride emitter window mask above said oxide and polysilicon layers; providing a wet etching with hydrofluoric acid solutions to etch said first and second

oxide layers;

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providing a horizontal plasma etching of said polysilicon layer, wherein the dimensions of the horizontally etched region determine that the dimensions of the base region are wider than the doped collector region and the emitter region of the transistor;

providing a doping of said collector region wherein the doped collector region is determined by the emitter window mask;

providing a base region above said collector region in the horizontally etched area; wherein the base region extends horizontally beyond the doped collector region;

providing an emitter region above the base region so that the emitter, base and collector regions are super self-aligned

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21. (New) A method for forming a super self-aligned bipolar transistor, comprising the steps

providing a semiconductor substrate having a buried collector region;

providing multiple layers above said collector region;

providing an emitter window mask above said multiple layers;

providing three vertical etchings of said multiple layers;

providing a doping of said collector region wherein the doped collector region is determined by the emitter window mask;

providing a horizontal etching of one of said multiple layers, wherein the step of providing a horizontal etching determines that the dimensions of the base region are wider than the dimensions of the doped collector region and the emitter region;

providing a wet etching to remove a final one of said multiple layers; and providing a base region above said collector region in the horizontally etched area; providing an emitter region above the base region so that the emitter, base and collector

regions are super self-aligned.

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- 22. (New) The method of claim 21 wherein the horizontal etching is performed to a distance greater than the polysilicon layer thickness, and whereby the distance may be conformed to provide desired electrical characteristics.
- 23. (New) The method of claim \$2\$ wherein the desired electrical characteristics are transistor gain and frequency response.

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